Carnegie Mellon University

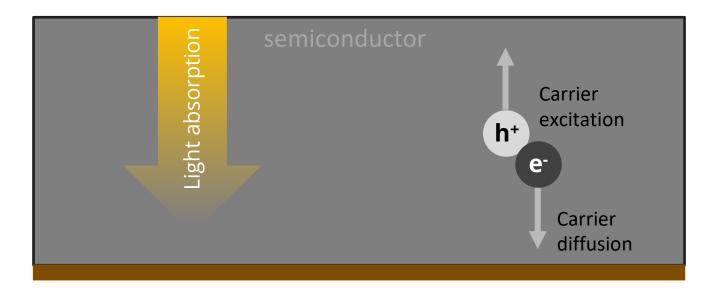
It's all about that Bayes: Data-driven insights into energy devices without the black box

PASC MINISYMPOSIUM ON INTERDISCIPLINARY CHALLENGES IN MULTISCALE MATERIALS MODELING JUNE 27, 2023

Rachel Kurchin

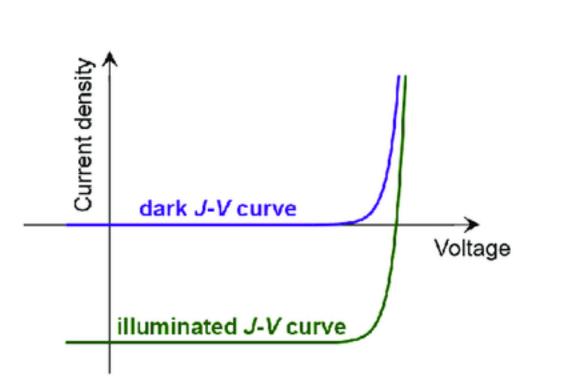
Assistant Research Professor Carnegie Mellon Materials Science and Engineering

Multiscale processes in photovoltaic devices



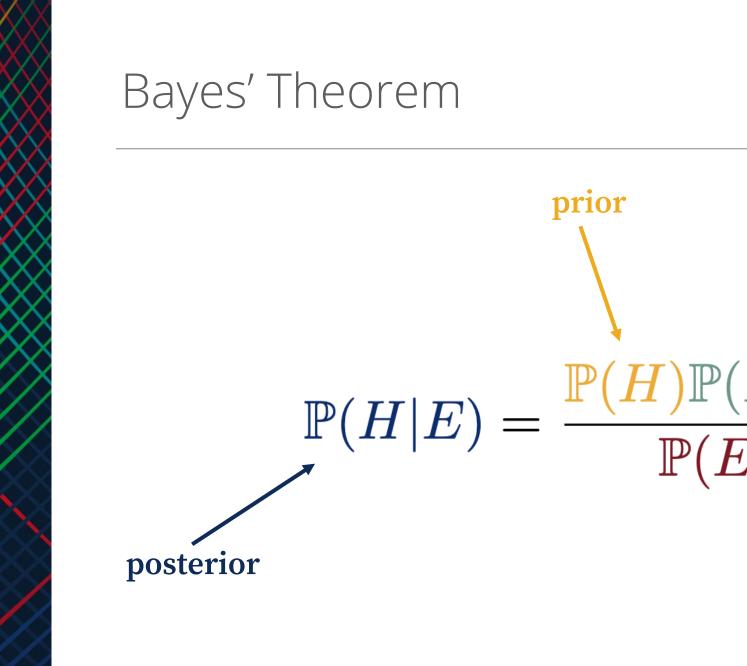
...including across interfaces and in the presence of defects (scattering!)...and in nonequilibrium conditions!

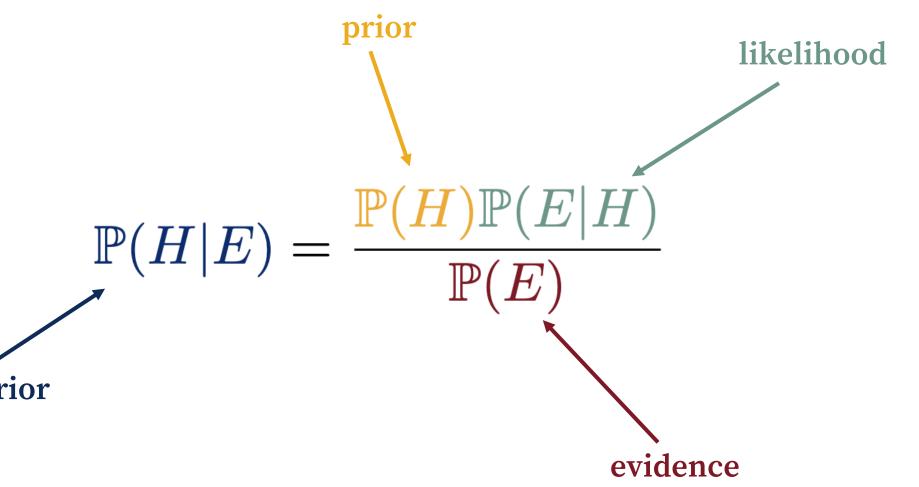
Electrical Characterization of Solar Cells



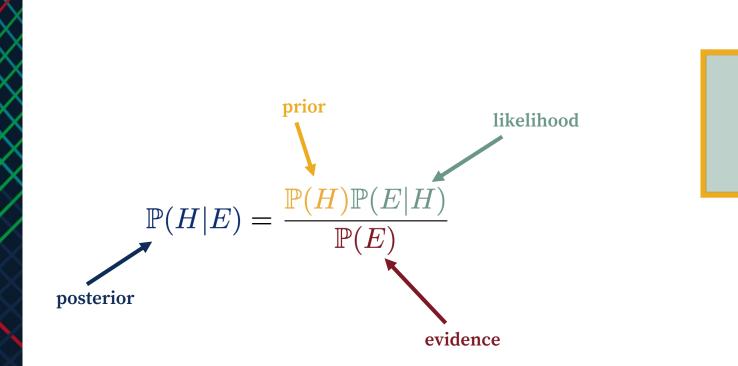
We can measure current as a function of voltage, light intensity, temperature, ...

...each of these "knobs" probes different processes in the device, and hence depends differently on its materials properties.



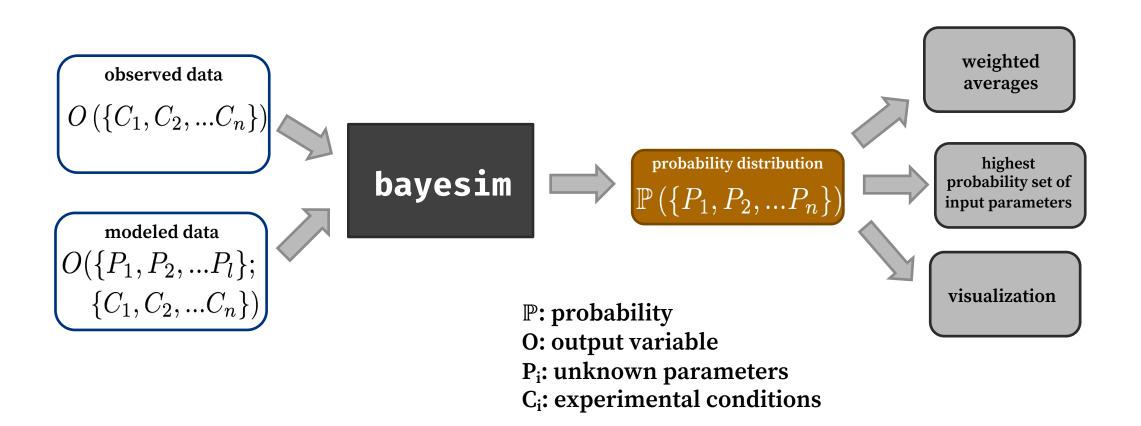


Bayes' Theorem



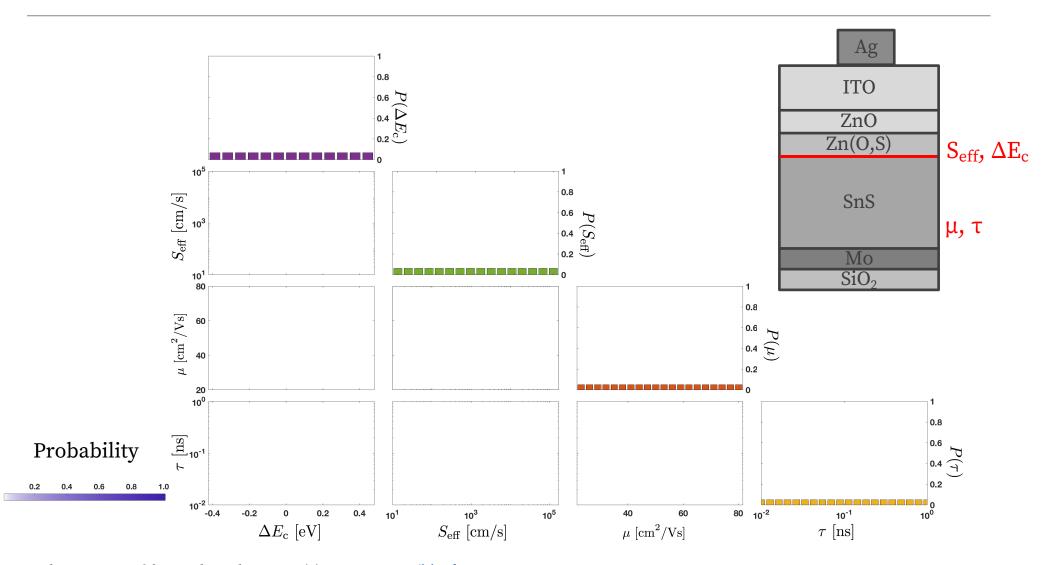
6 Bayesian parameter estimation Likelihood function comes from a SnS solar cell: forward model that tells us what we would measure *if* parameters took (with some unknown) particular values... *materials/interface properties)* Ag \mathbb{P} measurement ITO UPS: ~\$50k ZnO Zn(O,S) $S_{eff}, \Delta E_c$ Experimental error (noise) TRPL: ~\$10k SnS Model output / μ, measured quantity Mo SiO₂ Hall effect system: ~\$20k Modeled values

Bayesim: open-source BPE for expensive models



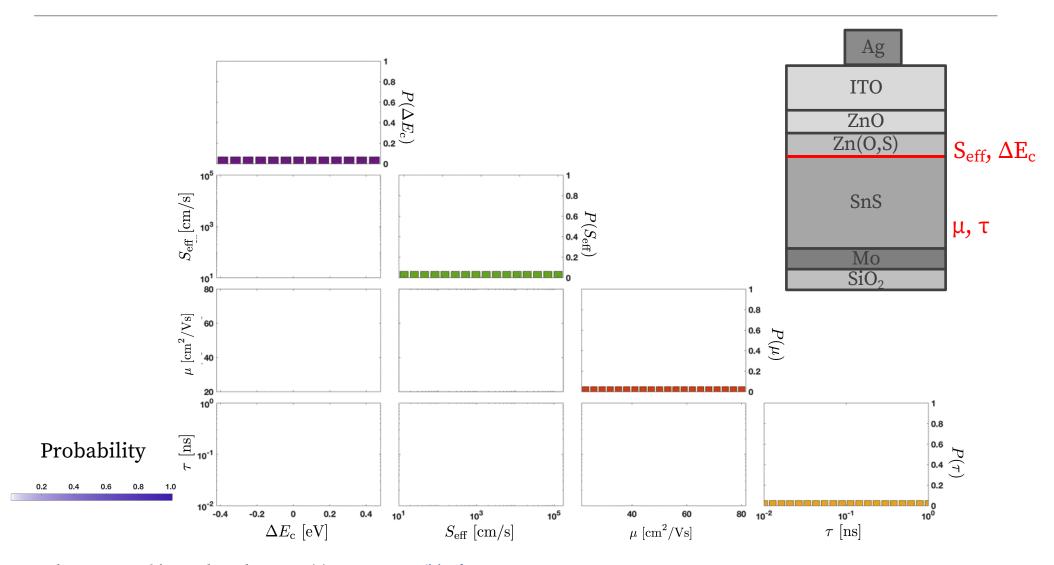
R. Kurchin, G. Romano, and T. Buonassisi. Computer Physics Communications 2019, 239, 161. 10.1016/j.cpc.2019.01.022

Tin Sulfide (SnS) Photovoltaics



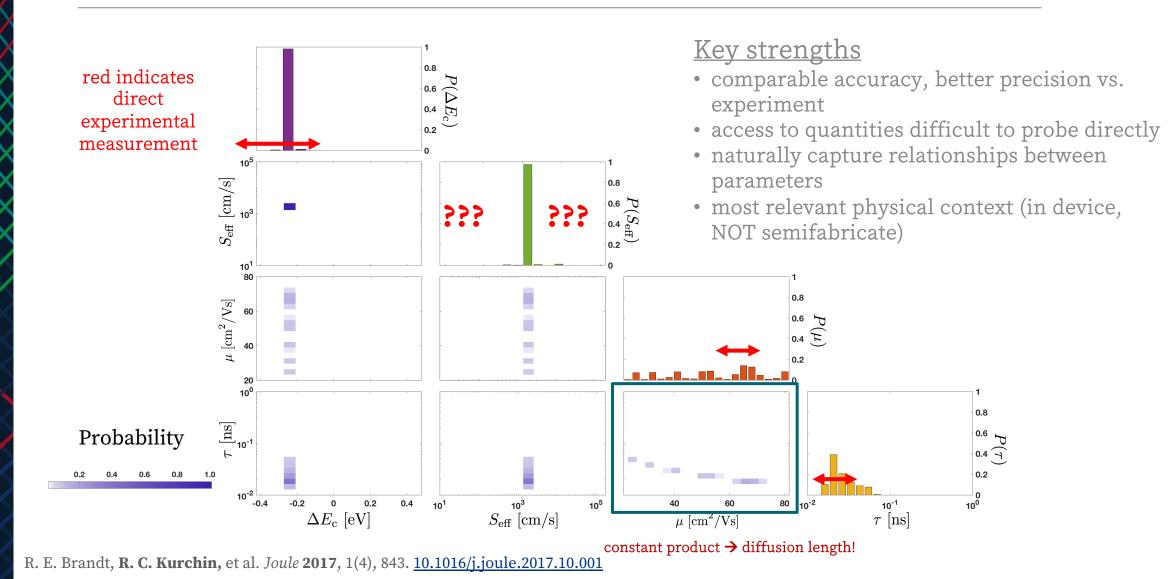
R. E. Brandt, R. C. Kurchin, et al. Joule 2017, 1(4), 843. <u>10.1016/j.joule.2017.10.001</u>

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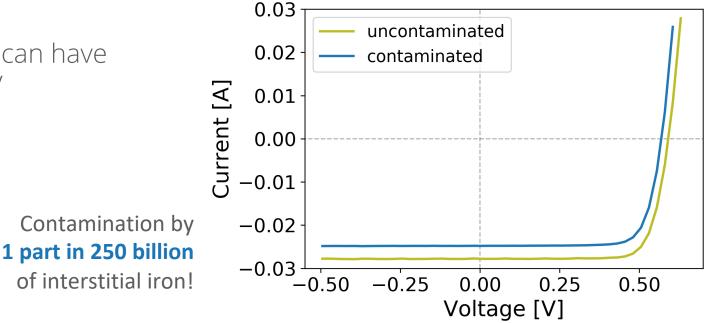
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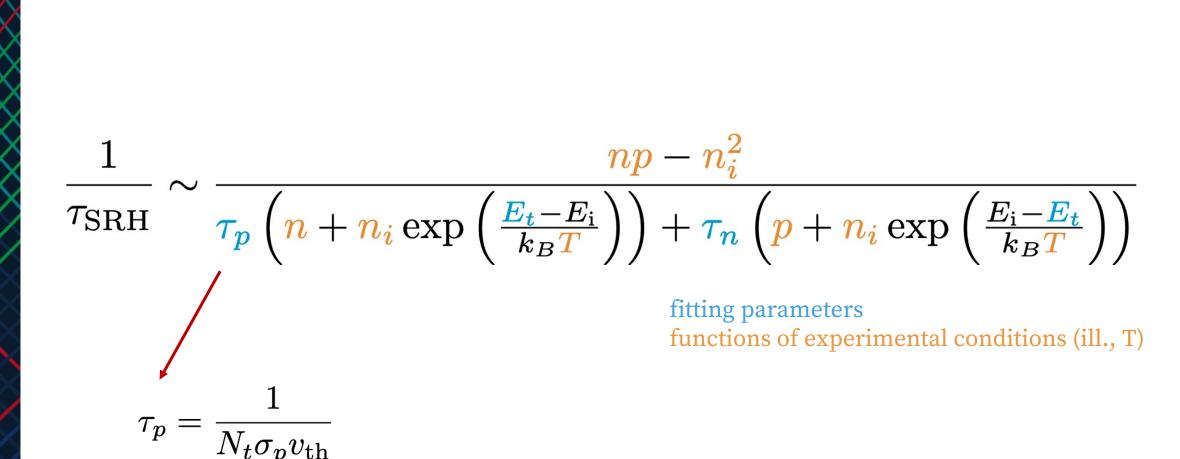


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Let's make this a little harder...

- Core intuition: anything that affects experimental measurement must have a *signal* in that measurement...so how much can we get?
- Properties of point defects are notoriously difficult to characterize...yet they can have dramatic effects on PV performance!

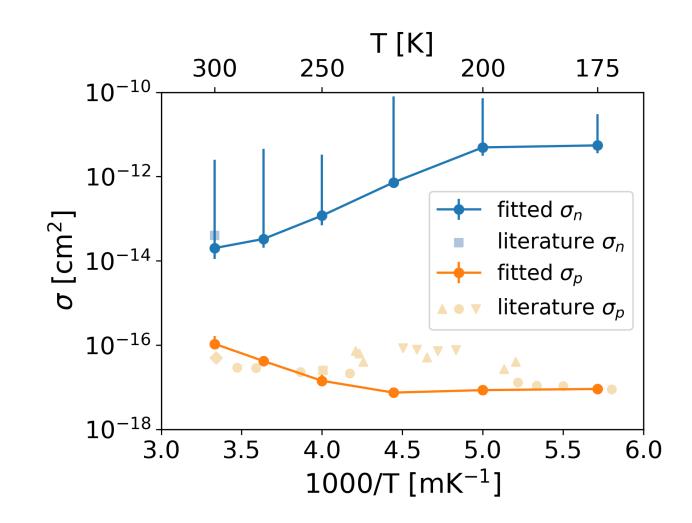




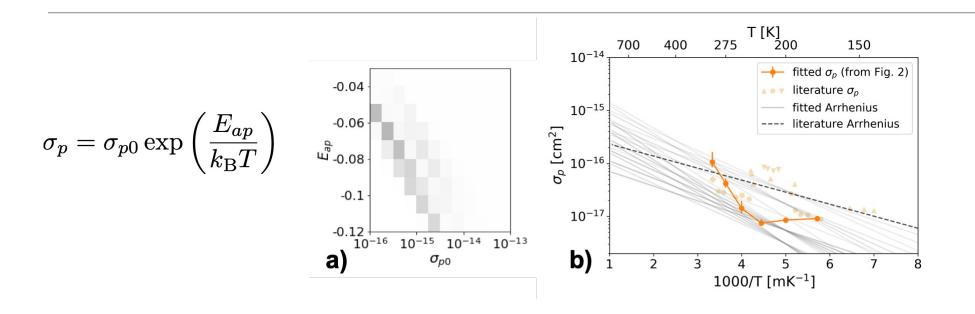
W. Shockley and W. Read. *Phys. Rev.* 1952, 87(46), 835. <u>10.1103/PhysRev.87.835</u>
R. N. Hall. *Phys. Rev.* 1952, 87(2), 387. <u>10.1103/PhysRev.87.387</u>
R. C. Kurchin et al. *IEEE Journal of Photovoltaics* 2020, 10(6) 1532. <u>10.1109/JPHOTOV.2020.3010105</u>

Defect-Assisted Recombination

Capture Cross-Sections vs. literature



Temperature Dependence of σ



condition on known activation energy...

R. C. Kurchin et al. *IEEE Journal of Photovoltaics* **2020**, 10(6) 1532. <u>10.1109/JPHOTOV.2020.3010105</u>

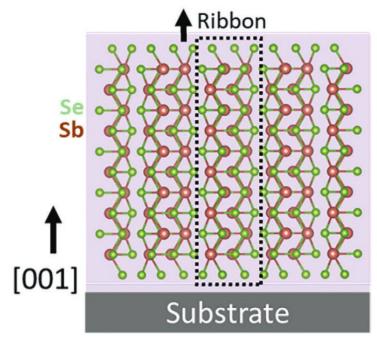
Summary so far...

- Validated a novel BPE-based approach to measuring materials properties from simple, automatable electrical measurements of solar cells
- Allows us to "trade off" expensive experimental effort for cheap(er) computations
- Redundantly good fits emerge naturally
- We can measure the most relevant "versions" of properties in most relevant context



Ongoing Work

 $Sb_2(S,Se)_3$: a promising class of novel Earthabundant thin-film PV absorbers





Experimental collaborators: Prof. Yanfa Yan, Alisha Adhikari



Goal: use BPE to accelerate not only the *characterization* of these materials/devices, but also their *engineering!*



What's next?

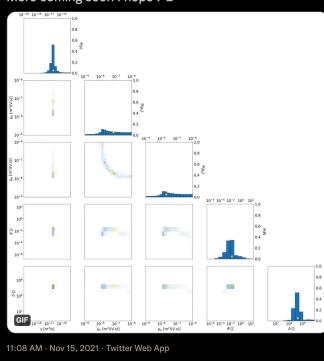
- Incorporate better sampling approaches to expand number of parameters we can afford to fit (e.g. VBMC)
- Extend beyond photovoltaics interested in using this approach in your system of interest? **Please come and chat!**

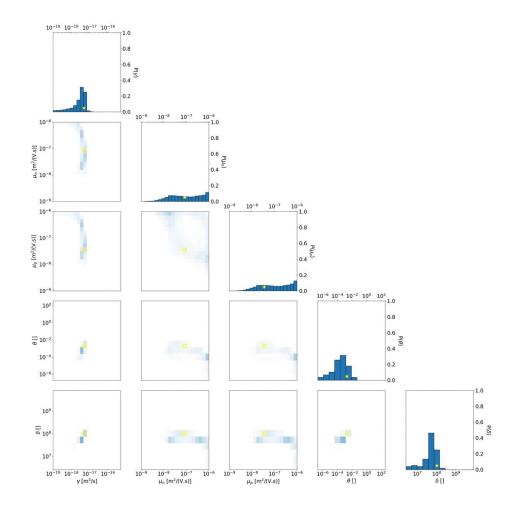


The beauty of open-source software!



The beauty of **#opensource** codes is that other people can go and play with them. Here, I adapted bayesim from @toniobuonassisi group and SIMsalabim from @JanAntonKoster1 More coming soon I hope :-D



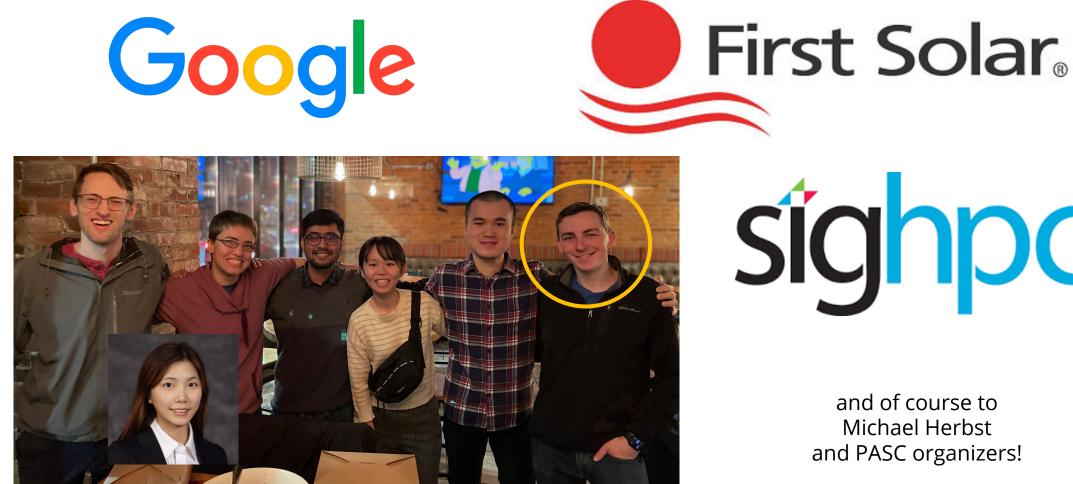


Thanks to Dr. Vincent Le Corre, University of Erlangen-Nuremberg!



Acknowledgements!





group website: https://https://acme-group-cmu.github.io/

and of course to Michael Herbst and PASC organizers!